

$\Delta(2350) \ 5/2^-$

$I(J^P) = \frac{3}{2}(\frac{5}{2}^-)$ Status: *

OMITTED FROM SUMMARY TABLE

$\Delta(2350)$ POLE POSITION

REAL PART

VALUE (MeV)	DOCUMENT ID	TECN	COMMENT
2400±125	CUTKOSKY 80	IPWA	$\pi N \rightarrow \pi N$
• • • We do not use the following data for averages, fits, limits, etc. • • •			
2427	VRANA 00	DPWA	Multichannel

−2×IMAGINARY PART

VALUE (MeV)	DOCUMENT ID	TECN	COMMENT
400±150	CUTKOSKY 80	IPWA	$\pi N \rightarrow \pi N$
• • • We do not use the following data for averages, fits, limits, etc. • • •			
458	VRANA 00	DPWA	Multichannel

$\Delta(2350)$ ELASTIC POLE RESIDUE

MODULUS $|r|$

VALUE (MeV)	DOCUMENT ID	TECN	COMMENT
15±8	CUTKOSKY 80	IPWA	$\pi N \rightarrow \pi N$

PHASE θ

VALUE (°)	DOCUMENT ID	TECN	COMMENT
−70±70	CUTKOSKY 80	IPWA	$\pi N \rightarrow \pi N$

$\Delta(2350)$ BREIT-WIGNER MASS

VALUE (MeV)	DOCUMENT ID	TECN	COMMENT
2400±125	CUTKOSKY 80	IPWA	$\pi N \rightarrow \pi N$
2305± 26	HOEHLER 79	IPWA	$\pi N \rightarrow \pi N$
• • • We do not use the following data for averages, fits, limits, etc. • • •			
2459±100	VRANA 00	DPWA	Multichannel

$\Delta(2350)$ BREIT-WIGNER WIDTH

VALUE (MeV)	DOCUMENT ID	TECN	COMMENT
400±150	CUTKOSKY 80	IPWA	$\pi N \rightarrow \pi N$
300± 70	HOEHLER 79	IPWA	$\pi N \rightarrow \pi N$
• • • We do not use the following data for averages, fits, limits, etc. • • •			
480±360	VRANA 00	DPWA	Multichannel

$\Delta(2350)$ DECAY MODES

Mode	Fraction (Γ_i/Γ)
$\Gamma_1 \quad N\pi$	4–30 %

$\Delta(2350)$ BRANCHING RATIOS

$\Gamma(N\pi)/\Gamma_{\text{total}}$					Γ_1/Γ
VALUE (%)	DOCUMENT ID	TECN	COMMENT		
20 ± 10	CUTKOSKY	80	IPWA	$\pi N \rightarrow \pi N$	
4 ± 2	HOEHLER	79	IPWA	$\pi N \rightarrow \pi N$	
• • • We do not use the following data for averages, fits, limits, etc. • • •					
7 ± 14	VRANA	00	DPWA	Multichannel	

$\Delta(2350)$ REFERENCES

VRANA	00	PRPL 328 181	T.P. Vrana, S.A. Dytman, T.-S.H. Lee	(PITT, ANL)
CUTKOSKY	80	Toronto Conf. 19	R.E. Cutkosky <i>et al.</i>	(CMU, LBL) IJP
Also		PR D20 2839	R.E. Cutkosky <i>et al.</i>	(CMU, LBL)
HOEHLER	79	PDAT 12-1	G. Hohler <i>et al.</i>	(KARLT) IJP
Also		Toronto Conf. 3	R. Koch	(KARLT) IJP